

## N - CHANNEL ENHANCEMENT MODE FAST POWER MOS TRANSISTOR

| TYPE       | V <sub>DSS</sub> | R <sub>DS(on)</sub> | I <sub>D</sub> |
|------------|------------------|---------------------|----------------|
| STP3NA50   | 500 V            | < 3 Ω               | 3.3 A          |
| STP3NA50FI | 500 V            | < 3 Ω               | 2.3 A          |

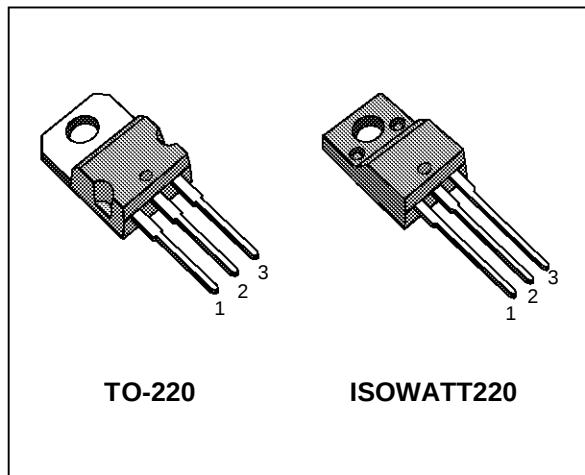
- TYPICAL R<sub>DS(on)</sub> = 2.4 Ω
- ± 30V GATE TO SOURCE VOLTAGE RATING
- 100% AVALANCHE TESTED
- REPETITIVE AVALANCHE DATA AT 100°C
- LOW INTRINSIC CAPACITANCES
- GATE CHARGE MINIMIZED
- REDUCED THRESHOLD VOLTAGE SPREAD

### DESCRIPTION

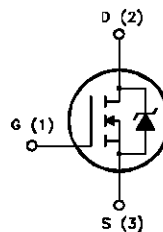
This series of POWER MOSFETS represents the most advanced high voltage technology. The optimized cell layout coupled with a new proprietary edge termination concur to give the device low R<sub>DS(on)</sub> and gate charge, unequalled ruggedness and superior switching performance.

### APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- SWITCH MODE POWER SUPPLIES (SMPS)
- DC-AC CONVERTERS FOR WELDING EQUIPMENT AND UNINTERRUPTIBLE POWER SUPPLIES AND MOTOR DRIVE



### INTERNAL SCHEMATIC DIAGRAM



### ABSOLUTE MAXIMUM RATINGS

| Symbol              | Parameter                                             | Value      |            | Unit |
|---------------------|-------------------------------------------------------|------------|------------|------|
|                     |                                                       | STP3NA50   | STP3NA50FI |      |
| V <sub>DS</sub>     | Drain-source Voltage (V <sub>GS</sub> = 0)            | 500        |            | V    |
| V <sub>DGR</sub>    | Drain-gate Voltage (R <sub>GS</sub> = 20 kΩ)          | 500        |            | V    |
| V <sub>GS</sub>     | Gate-source Voltage                                   | ± 30       |            | V    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>c</sub> = 25 °C  | 3.3        | 2.3        | A    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>c</sub> = 100 °C | 2.1        | 1.5        | A    |
| I <sub>DM</sub> (•) | Drain Current (pulsed)                                | 13.2       | 13.2       | A    |
| P <sub>tot</sub>    | Total Dissipation at T <sub>c</sub> = 25 °C           | 80         | 40         | W    |
|                     | Derating Factor                                       | 0.64       | 0.32       | W/°C |
| V <sub>ISO</sub>    | Insulation Withstand Voltage (DC)                     | —          | 2000       | V    |
| T <sub>stg</sub>    | Storage Temperature                                   | -65 to 150 |            | °C   |
| T <sub>j</sub>      | Max. Operating Junction Temperature                   | 150        |            | °C   |

(•) Pulse width limited by safe operating area

## THERMAL DATA

|                       |                                                |     |  | TO-220 | ISOWATT220 |      |
|-----------------------|------------------------------------------------|-----|--|--------|------------|------|
| R <sub>thj-case</sub> | Thermal Resistance Junction-case               | Max |  | 1.56   | 3.12       | °C/W |
| R <sub>thj-amb</sub>  | Thermal Resistance Junction-ambient            | Max |  | 62.5   |            | °C/W |
| R <sub>thc-sink</sub> | Thermal Resistance Case-sink                   | Typ |  | 0.5    |            | °C/W |
| T <sub>l</sub>        | Maximum Lead Temperature For Soldering Purpose |     |  | 300    |            | °C   |

## AVALANCHE CHARACTERISTICS

| Symbol          | Parameter                                                                                                                    | Max Value | Unit |
|-----------------|------------------------------------------------------------------------------------------------------------------------------|-----------|------|
| I <sub>AR</sub> | Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T <sub>j</sub> max, δ < 1%)                          | 3.3       | A    |
| E <sub>AS</sub> | Single Pulse Avalanche Energy (starting T <sub>j</sub> = 25 °C, I <sub>D</sub> = I <sub>AR</sub> , V <sub>DD</sub> = 50 V)   | 55        | mJ   |
| E <sub>AR</sub> | Repetitive Avalanche Energy (pulse width limited by T <sub>j</sub> max, δ < 1%)                                              | 2.2       | mJ   |
| I <sub>AR</sub> | Avalanche Current, Repetitive or Not-Repetitive (T <sub>c</sub> = 100 °C, pulse width limited by T <sub>j</sub> max, δ < 1%) | 2.1       | A    |

ELECTRICAL CHARACTERISTICS (T<sub>case</sub> = 25 °C unless otherwise specified)

## OFF

| Symbol               | Parameter                                             | Test Conditions                                                                            | Min. | Typ. | Max.      | Unit     |
|----------------------|-------------------------------------------------------|--------------------------------------------------------------------------------------------|------|------|-----------|----------|
| V <sub>(BR)DSS</sub> | Drain-source Breakdown Voltage                        | I <sub>D</sub> = 250 μA V <sub>GS</sub> = 0                                                | 500  |      |           | V        |
| I <sub>DSS</sub>     | Zero Gate Voltage Drain Current (V <sub>GS</sub> = 0) | V <sub>DS</sub> = Max Rating<br>V <sub>DS</sub> = Max Rating x 0.8 T <sub>c</sub> = 125 °C |      |      | 25<br>250 | μA<br>μA |
| I <sub>GSS</sub>     | Gate-body Leakage Current (V <sub>DS</sub> = 0)       | V <sub>GS</sub> = ± 30 V                                                                   |      |      | ± 100     | nA       |

## ON (\*)

| Symbol              | Parameter                         | Test Conditions                                                                         | Min. | Typ. | Max. | Unit |
|---------------------|-----------------------------------|-----------------------------------------------------------------------------------------|------|------|------|------|
| V <sub>GS(th)</sub> | Gate Threshold Voltage            | V <sub>DS</sub> = V <sub>GS</sub> I <sub>D</sub> = 250 μA                               | 2.25 | 3    | 3.75 | V    |
| R <sub>DS(on)</sub> | Static Drain-source On Resistance | V <sub>GS</sub> = 10V I <sub>D</sub> = 1.5 A                                            |      | 2.4  | 3    | Ω    |
| I <sub>D(on)</sub>  | On State Drain Current            | V <sub>DS</sub> > I <sub>D(on)</sub> x R <sub>DS(on)max</sub><br>V <sub>GS</sub> = 10 V | 3.3  |      |      | A    |

## DYNAMIC

| Symbol              | Parameter                    | Test Conditions                                                                      | Min. | Typ. | Max. | Unit |
|---------------------|------------------------------|--------------------------------------------------------------------------------------|------|------|------|------|
| g <sub>fs</sub> (*) | Forward Transconductance     | V <sub>DS</sub> > I <sub>D(on)</sub> x R <sub>DS(on)max</sub> I <sub>D</sub> = 1.5 A | 1.2  | 2.2  |      | S    |
| C <sub>iss</sub>    | Input Capacitance            | V <sub>DS</sub> = 25 V f = 1 MHz V <sub>GS</sub> = 0                                 |      | 370  | 485  | pF   |
| C <sub>oss</sub>    | Output Capacitance           |                                                                                      |      | 62   | 81   | pF   |
| C <sub>rss</sub>    | Reverse Transfer Capacitance |                                                                                      |      | 20   | 27   | pF   |

**ELECTRICAL CHARACTERISTICS** (continued)**SWITCHING ON**

| Symbol                        | Parameter                                                    | Test Conditions                                                                                                           | Min. | Typ.         | Max.     | Unit           |
|-------------------------------|--------------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------|------|--------------|----------|----------------|
| $t_{d(on)}$<br>$t_r$          | Turn-on Time<br>Rise Time                                    | $V_{DD} = 250\text{ V}$ $I_D = 1.5\text{ A}$<br>$R_G = 18\ \Omega$ $V_{GS} = 10\text{ V}$<br>(see test circuit, figure 3) |      | 14<br>23     | 20<br>30 | ns<br>ns       |
| $(di/dt)_{on}$                | Turn-on Current Slope                                        | $V_{DD} = 400\text{ V}$ $I_D = 3\text{ A}$<br>$R_G = 18\ \Omega$ $V_{GS} = 10\text{ V}$<br>(see test circuit, figure 5)   |      | 340          |          | A/ $\mu$ s     |
| $Q_g$<br>$Q_{gs}$<br>$Q_{gd}$ | Total Gate Charge<br>Gate-Source Charge<br>Gate-Drain Charge | $V_{DD} = 400\text{ V}$ $I_D = 3\text{ A}$ $V_{GS} = 10\text{ V}$                                                         |      | 21<br>6<br>9 | 28       | nC<br>nC<br>nC |

**SWITCHING OFF**

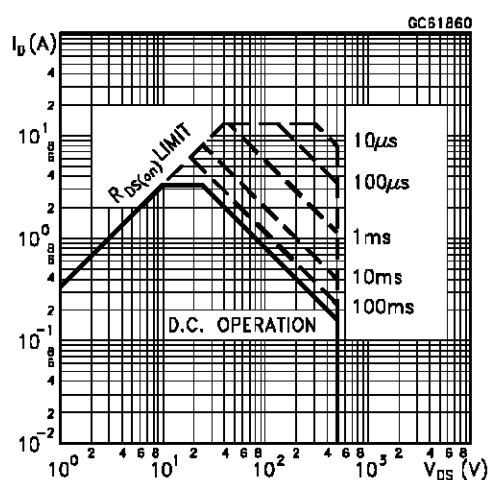
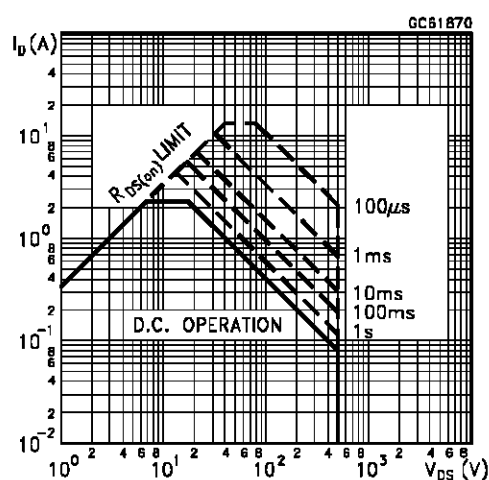
| Symbol                           | Parameter                                             | Test Conditions                                                                                                         | Min. | Typ.           | Max.           | Unit           |
|----------------------------------|-------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------|------|----------------|----------------|----------------|
| $t_r(V_{off})$<br>$t_f$<br>$t_c$ | Off-voltage Rise Time<br>Fall Time<br>Cross-over Time | $V_{DD} = 400\text{ V}$ $I_D = 3\text{ A}$<br>$R_G = 18\ \Omega$ $V_{GS} = 10\text{ V}$<br>(see test circuit, figure 5) |      | 13<br>11<br>26 | 18<br>16<br>35 | ns<br>ns<br>ns |

**SOURCE DRAIN DIODE**

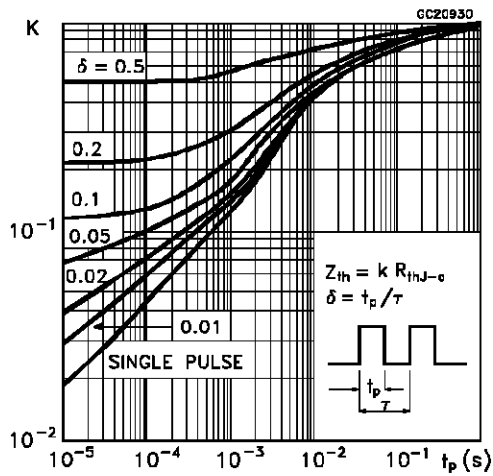
| Symbol                            | Parameter                                                                             | Test Conditions                                                                                                                                       | Min. | Typ.             | Max.        | Unit               |
|-----------------------------------|---------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------|------|------------------|-------------|--------------------|
| $I_{SD}$<br>$I_{SDM}(\bullet)$    | Source-drain Current<br>Source-drain Current<br>(pulsed)                              |                                                                                                                                                       |      |                  | 3.3<br>13.2 | A<br>A             |
| $V_{SD} (*)$                      | Forward On Voltage                                                                    | $I_{SD} = 3.3\text{ A}$ $V_{GS} = 0$                                                                                                                  |      |                  | 1.6         | V                  |
| $t_{rr}$<br>$Q_{rr}$<br>$I_{RRM}$ | Reverse Recovery<br>Time<br>Reverse Recovery<br>Charge<br>Reverse Recovery<br>Current | $I_{SD} = 3\text{ A}$ $di/dt = 100\text{ A}/\mu\text{s}$<br>$V_{DD} = 100\text{ V}$ $T_J = 150\text{ }^\circ\text{C}$<br>(see test circuit, figure 5) |      | 350<br>4.2<br>24 |             | ns<br>$\mu$ C<br>A |

(\*) Pulsed: Pulse duration = 300  $\mu$ s, duty cycle 1.5 %

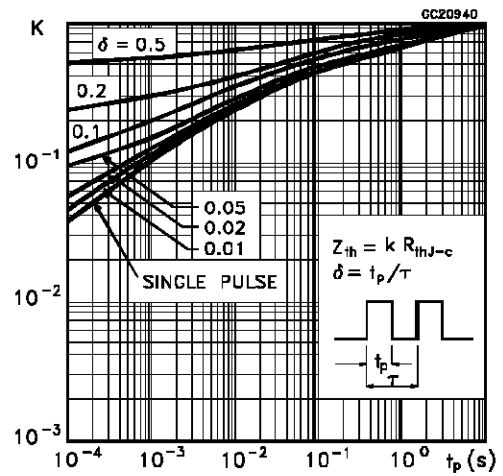
(•) Pulse width limited by safe operating area

**Safe Operating Areas for TO-220****Safe Operating Areas for ISOWATT220**

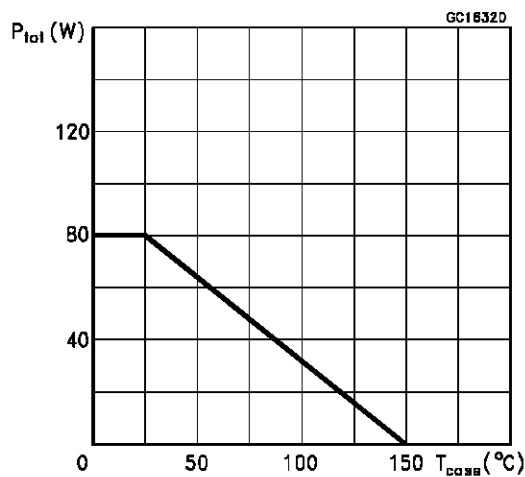
Thermal Impedance For TO-220



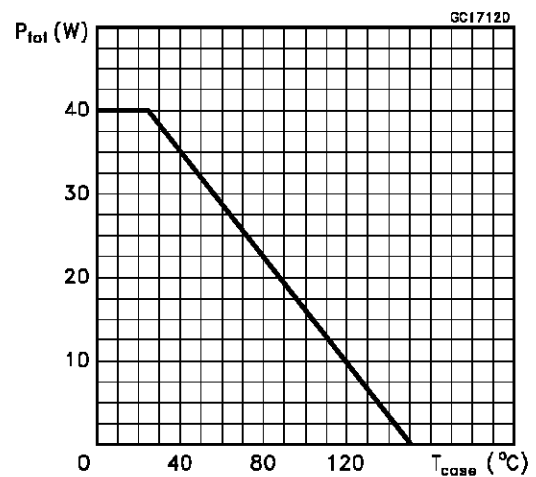
Thermal Impedance For ISOWATT220



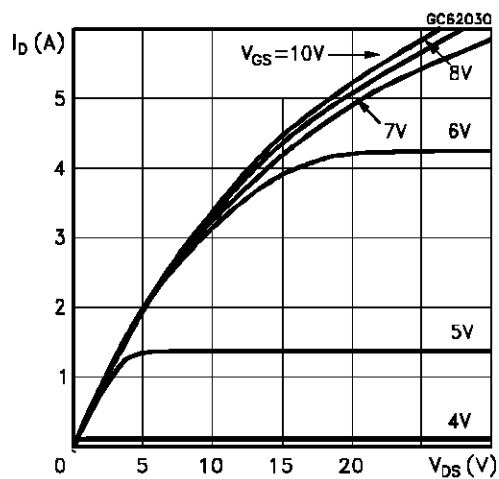
Derating Curve For TO-220



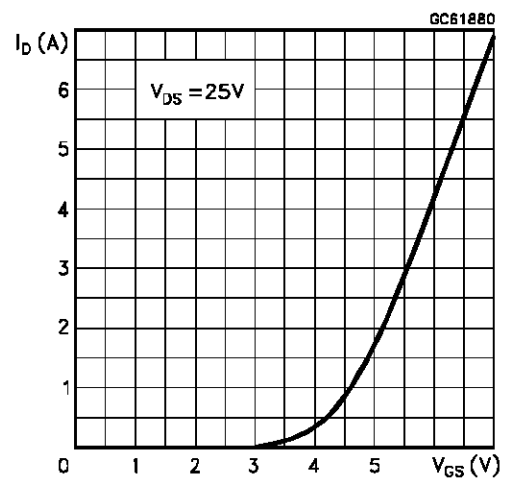
Derating Curve For ISOWATT220



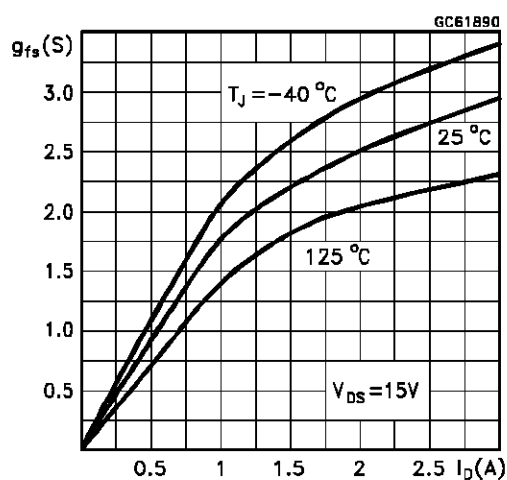
Output Characteristics



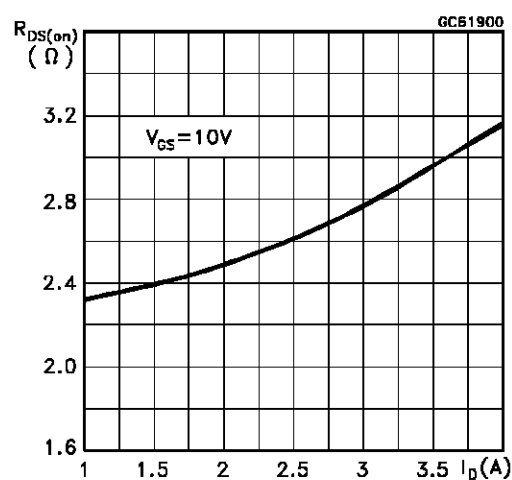
Transfer Characteristics



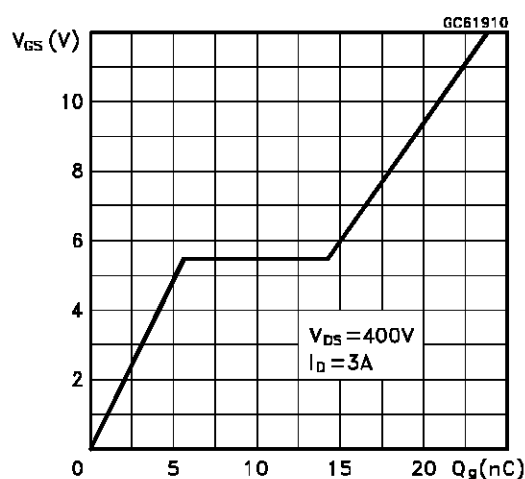
Transconductance



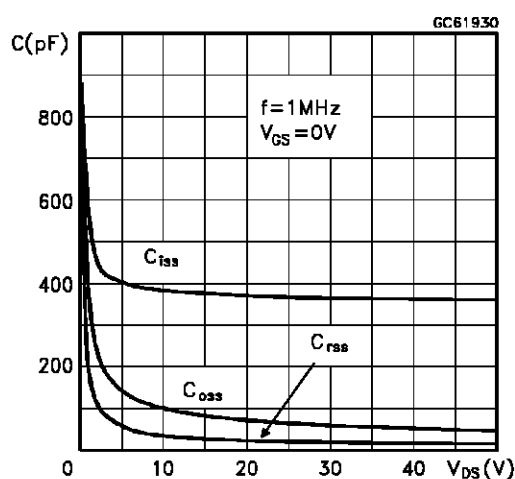
Static Drain-source On Resistance



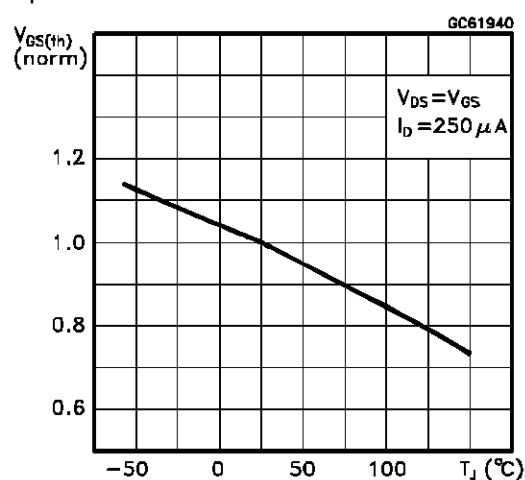
Gate Charge vs Gate-source Voltage



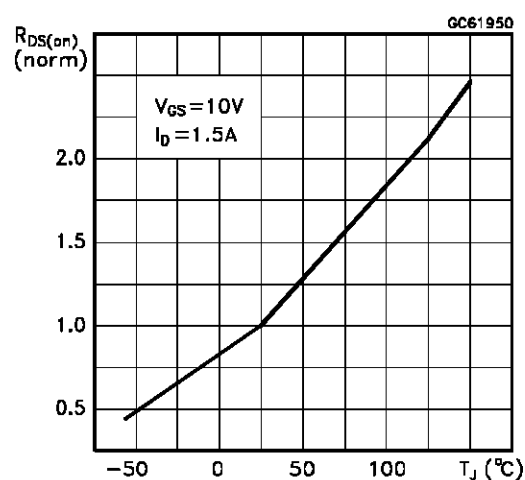
Capacitance Variations



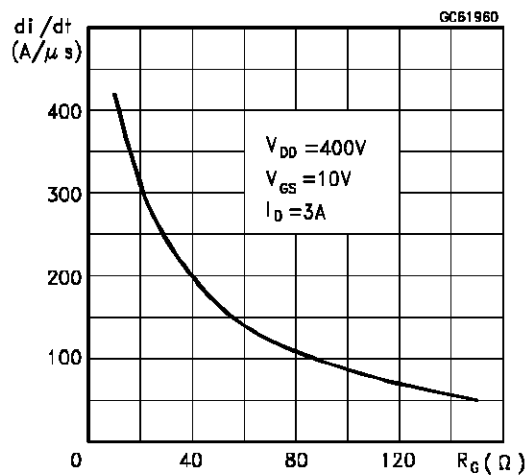
Normalized Gate Threshold Voltage vs Temperature



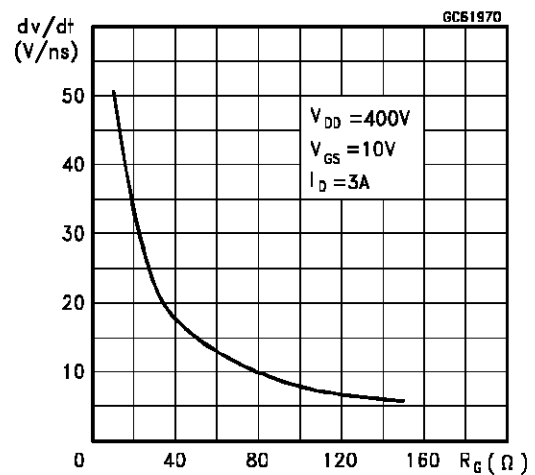
Normalized On Resistance vs Temperature



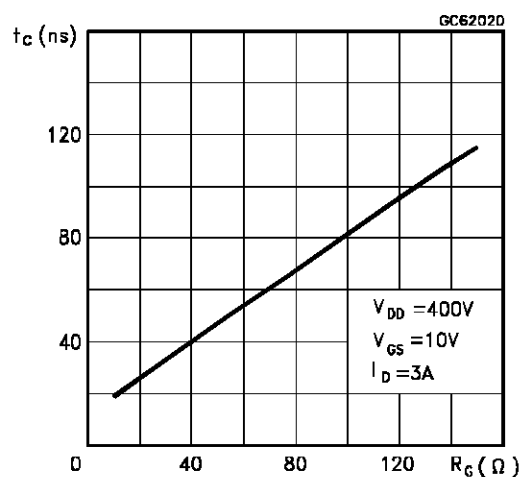
Turn-on Current Slope



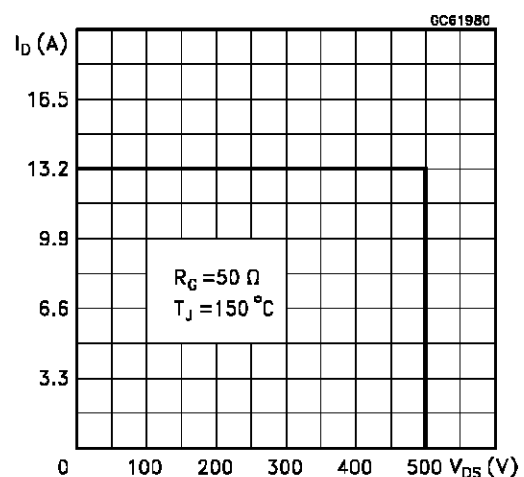
Turn-off Drain-source Voltage Slope



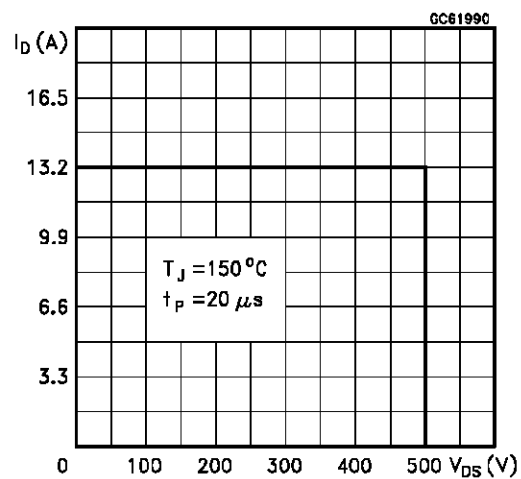
Cross-over Time



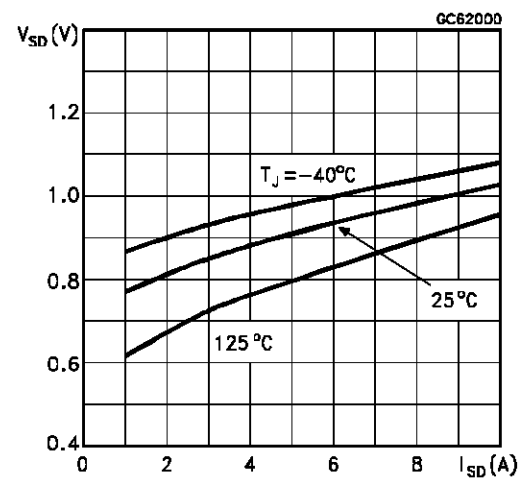
Switching Safe Operating Area



Accidental Overload Area



Source-drain Diode Forward Characteristics



**Fig. 1:** Unclamped Inductive Load Test Circuits**Fig. 2:** Unclamped Inductive Waveforms**Fig. 3:** Switching Times Test Circuits For Resistive Load**Fig. 4:** Gate Charge Test Circuit**Fig. 5:** Test Circuit For Inductive Load Switching And Diode Reverse Recovery Time

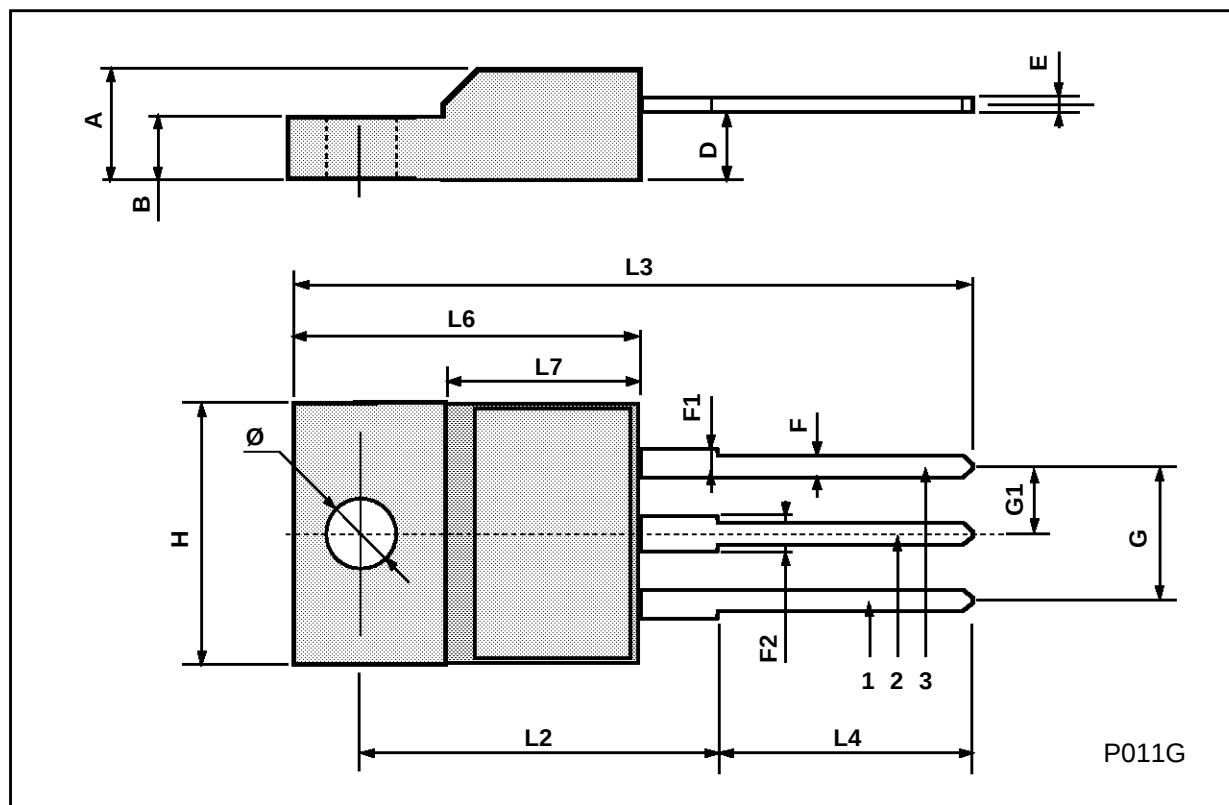
## TO-220 MECHANICAL DATA

| DIM. | mm    |      |       | inch  |       |       |
|------|-------|------|-------|-------|-------|-------|
|      | MIN.  | TYP. | MAX.  | MIN.  | TYP.  | MAX.  |
| A    | 4.40  |      | 4.60  | 0.173 |       | 0.181 |
| C    | 1.23  |      | 1.32  | 0.048 |       | 0.051 |
| D    | 2.40  |      | 2.72  | 0.094 |       | 0.107 |
| D1   |       | 1.27 |       |       | 0.050 |       |
| E    | 0.49  |      | 0.70  | 0.019 |       | 0.027 |
| F    | 0.61  |      | 0.88  | 0.024 |       | 0.034 |
| F1   | 1.14  |      | 1.70  | 0.044 |       | 0.067 |
| F2   | 1.14  |      | 1.70  | 0.044 |       | 0.067 |
| G    | 4.95  |      | 5.15  | 0.194 |       | 0.203 |
| G1   | 2.4   |      | 2.7   | 0.094 |       | 0.106 |
| H2   | 10.0  |      | 10.40 | 0.393 |       | 0.409 |
| L2   |       | 16.4 |       |       | 0.645 |       |
| L4   | 13.0  |      | 14.0  | 0.511 |       | 0.551 |
| L5   | 2.65  |      | 2.95  | 0.104 |       | 0.116 |
| L6   | 15.25 |      | 15.75 | 0.600 |       | 0.620 |
| L7   | 6.2   |      | 6.6   | 0.244 |       | 0.260 |
| L9   | 3.5   |      | 3.93  | 0.137 |       | 0.154 |
| DIA. | 3.75  |      | 3.85  | 0.147 |       | 0.151 |



## ISOWATT220 MECHANICAL DATA

| DIM. | mm   |      |      | inch  |       |       |
|------|------|------|------|-------|-------|-------|
|      | MIN. | TYP. | MAX. | MIN.  | TYP.  | MAX.  |
| A    | 4.4  |      | 4.6  | 0.173 |       | 0.181 |
| B    | 2.5  |      | 2.7  | 0.098 |       | 0.106 |
| D    | 2.5  |      | 2.75 | 0.098 |       | 0.108 |
| E    | 0.4  |      | 0.7  | 0.015 |       | 0.027 |
| F    | 0.75 |      | 1    | 0.030 |       | 0.039 |
| F1   | 1.15 |      | 1.7  | 0.045 |       | 0.067 |
| F2   | 1.15 |      | 1.7  | 0.045 |       | 0.067 |
| G    | 4.95 |      | 5.2  | 0.195 |       | 0.204 |
| G1   | 2.4  |      | 2.7  | 0.094 |       | 0.106 |
| H    | 10   |      | 10.4 | 0.393 |       | 0.409 |
| L2   |      | 16   |      |       | 0.630 |       |
| L3   | 28.6 |      | 30.6 | 1.126 |       | 1.204 |
| L4   | 9.8  |      | 10.6 | 0.385 |       | 0.417 |
| L6   | 15.9 |      | 16.4 | 0.626 |       | 0.645 |
| L7   | 9    |      | 9.3  | 0.354 |       | 0.366 |
| Ø    | 3    |      | 3.2  | 0.118 |       | 0.126 |



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